

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination JEON, HYOUNG-WOO	
		Examiner HELEN SHIBRU	Art Unit 2621	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0043784	11-2001	Shirata et al.	386/21
	B	US-			
	C	US-			
	D	US-			
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FOREIGN PATENT DOCUMENTS

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